

### Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness
- Resistant to Latch-Up
- Halogen Free, RoHS Compliant

### Benefits

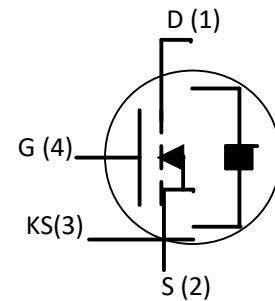
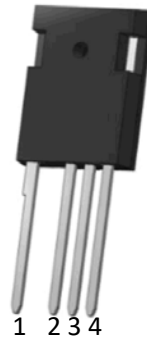
- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

### Applications

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC converters
- Battery Chargers
- Motor Drive
- Pulsed Power Applications

### Package

#### Package



### Maximum Ratings ( $T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
$V_{DSmax}$	Drain - Source Voltage	1200	V	$V_{GS} = 0\text{ V}, I_D = 100\ \mu\text{A}$	
$V_{GSmax}$	Gate - Source Voltage	-10/+25	V	Absolute maximum values	
$V_{GSop}$	Gate - Source Voltage	-5/+20	V	Recommended operational values	
$I_D$	Continuous Drain Current	90	A	$V_{GS} = 20\text{ V}, T_C = 25^\circ\text{C}$	Fig. 19
		60		$V_{GS} = 20\text{ V}, T_C = 100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	250	A	Pulse width $t_p$ limited by $T_{jmax}$	Fig. 22
$P_D$	Power Dissipation	463	W	$T_c = 25^\circ\text{C}, T_J = 150^\circ\text{C}$	Fig. 20
$T_J, T_{stg}$	Operating Junction and Storage Temperature	-55 to +150	$^\circ\text{C}$		
$T_L$	Solder Temperature	260	$^\circ\text{C}$	1.6mm (0.063") from case for 10s	
$M_d$	Mounting Torque	1 8.8	Nm lbf-in	M3 or 6-32 screw	

### Electrical Characteristics (T<sub>c</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	1200			V	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 100 μA	
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	2.5	4	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 15mA	Fig. 11
			1.8		V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 15mA, T <sub>J</sub> = 150 °C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		2	100	μA	V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V	
I <sub>GSS</sub>	Gate-Source Leakage Current			600	nA	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V	
R <sub>DS(on)</sub>	Drain-Source On-State Resistance		27	38	mΩ	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 50 A	Fig. 4,5,6
			37			V <sub>GS</sub> = 20 V, I <sub>D</sub> = 50 A, T <sub>J</sub> = 150 °C	
g <sub>fs</sub>	Transconductance		15.6		S	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 50 A	Fig. 7
			14.3			V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 50 A, T <sub>J</sub> = 150 °C	
C <sub>iss</sub>	Input Capacitance		4700		pF	V <sub>GS</sub> = 0 V	Fig. 17,18
C <sub>oss</sub>	Output Capacitance		231			V <sub>DS</sub> = 1000 V	
C <sub>rss</sub>	Reverse Transfer Capacitance		42.8			f = 1 MHz	
E <sub>oss</sub>	C <sub>oss</sub> Stored Energy		121		μJ	V <sub>AC</sub> = 25 mV	Fig 16
E <sub>AS</sub>	Avalanche Energy, Single Pluse		2.6		J	I <sub>D</sub> = 50A, V <sub>DD</sub> = 50V	Fig. 29
E <sub>ON</sub>	Turn-On Switching Energy		2.2		mJ	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = -5/20 V, I <sub>D</sub> = 50A, R <sub>G(ext)</sub> = 2.5Ω, L = 412 μH	Fig. 25
E <sub>OFF</sub>	Turn Off Switching Energy		0.5				
t <sub>d(on)</sub>	Turn-On Delay Time		62		ns	V <sub>DD</sub> = 800 V, V <sub>GS</sub> = -5/20 V I <sub>D</sub> = 50 A, R <sub>G(ext)</sub> = 2.5 Ω, R <sub>L</sub> = 16 Ω Timing relative to V <sub>DS</sub> Per IEC60747-8-4 pg 83	Fig. 27
t <sub>r</sub>	Rise Time		93				
t <sub>d(off)</sub>	Turn-Off Delay Time		60				
t <sub>f</sub>	Fall Time		39				
R <sub>G(int)</sub>	Internal Gate Resistance		0.8		Ω	f = 1 MHz, V <sub>AC</sub> = 25 mV, ESR of C <sub>ISS</sub>	
Q <sub>gs</sub>	Gate to Source Charge		58		nC	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = -5/20 V I <sub>D</sub> = 50 A Per IEC60747-8-4 pg 83	Fig. 12
Q <sub>gd</sub>	Gate to Drain Charge		90				
Q <sub>g</sub>	Total Gate Charge		185				

### Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V <sub>SD</sub>	Diode Forward Voltage	3.6		V	V <sub>GS</sub> = -5 V, I <sub>SD</sub> = 25 A	Fig. 8, 9, 10
		3.4		V	V <sub>GS</sub> = -5 V, I <sub>SD</sub> = 25 A, T <sub>J</sub> = 150 °C	
I <sub>S</sub>	Continuous Diode Forward Current		90		T <sub>C</sub> = 25 °C	Note 1
t <sub>rr</sub>	Reverse Recovery Time	45		ns	V <sub>GS</sub> = -5 V, I <sub>SD</sub> = 50 A, T <sub>J</sub> = 25 °C VR = 800 V dif/dt = 1000 A/μs	Note 1
Q <sub>rr</sub>	Reverse Recovery Charge	406		nC		
I <sub>rrm</sub>	Peak Reverse Recovery Current	13.5		A		

Note (1): When using SiC Body Diode the maximum recommended V<sub>GS</sub> = -5V

### Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
R <sub>θJC</sub>	Thermal Resistance from Junction to Case	0.24	0.27	°C/W		Fig. 21
R <sub>θJA</sub>	Thermal Resistance from Junction to Ambient		40			

Typical Performance

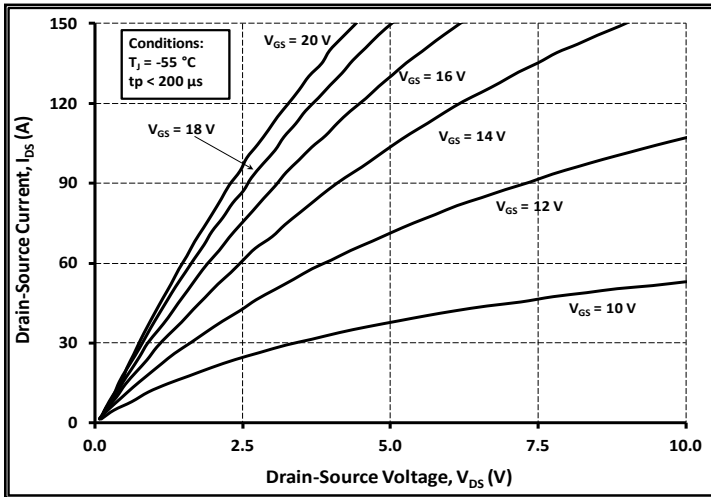


Figure 1. Output Characteristics  $T_J = -55\text{ }^\circ\text{C}$

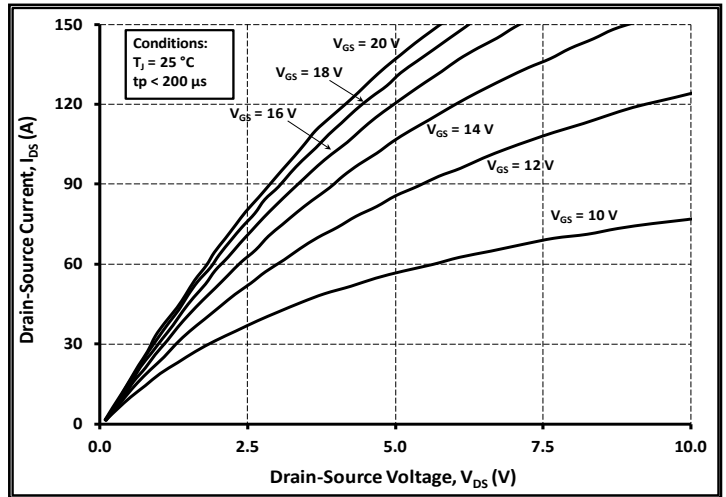


Figure 2. Output Characteristics  $T_J = 25\text{ }^\circ\text{C}$

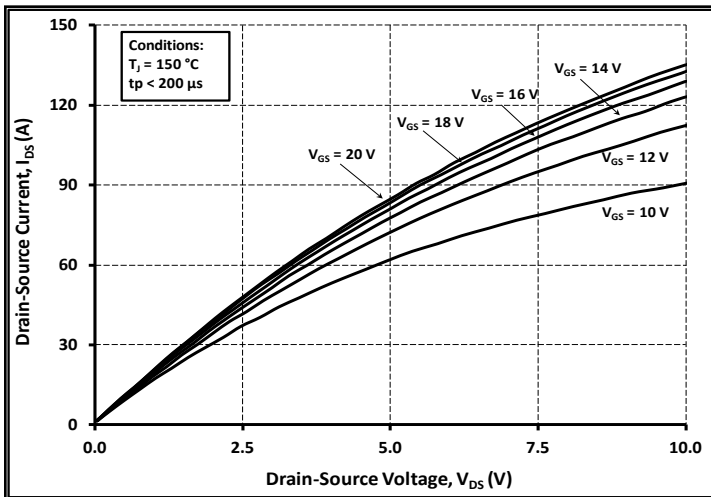


Figure 3. Output Characteristics  $T_J = 150\text{ }^\circ\text{C}$

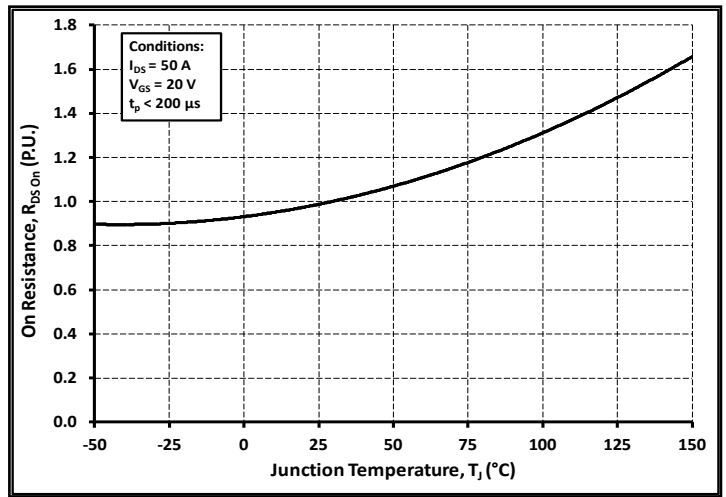


Figure 4. Normalized On-Resistance vs. Temperature

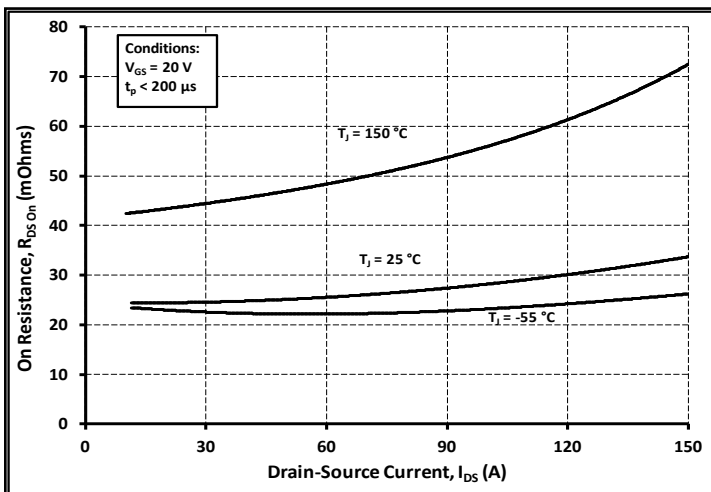


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

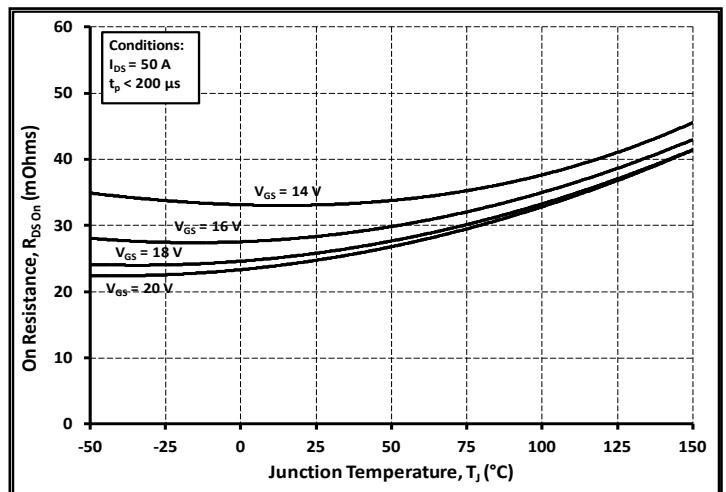


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

Typical Performance

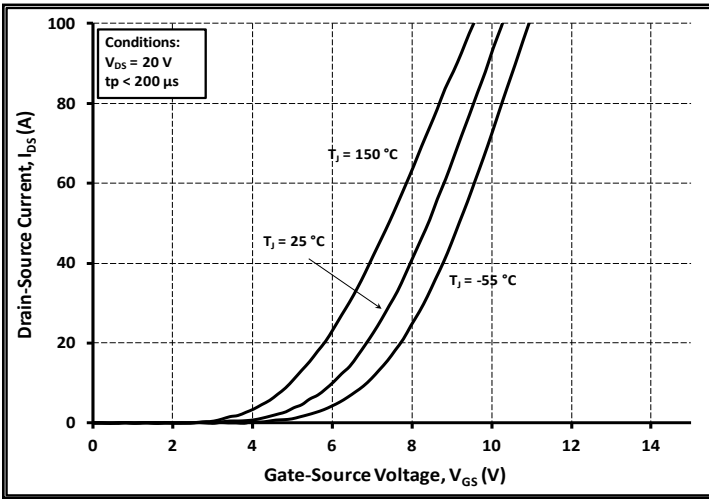


Figure 7. Transfer Characteristic For Various Junction Temperatures

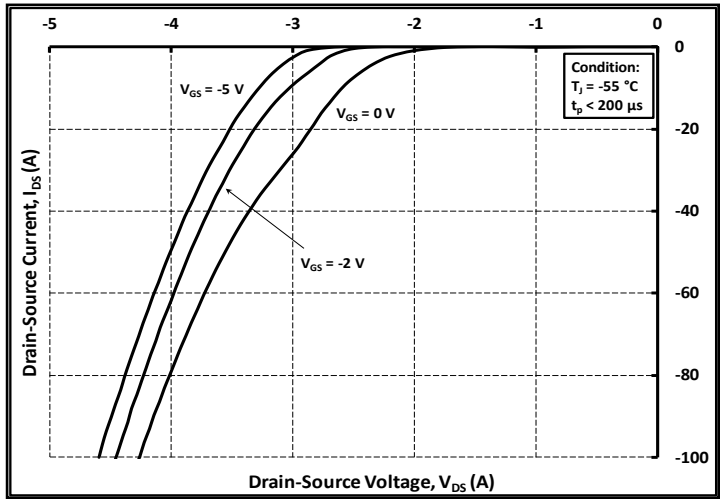


Figure 8. Body Diode Characteristic at -55 °C

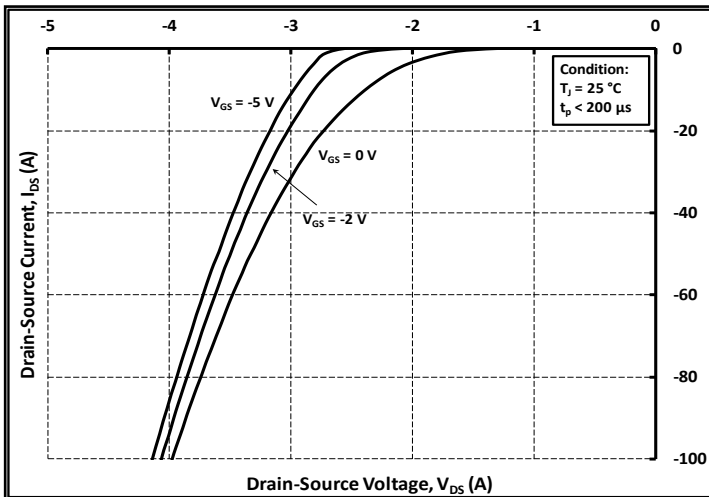


Figure 9. Body Diode Characteristic at 25 °C

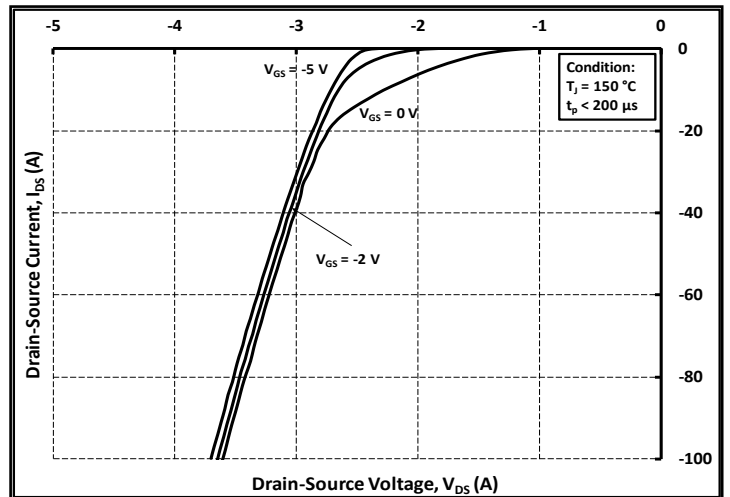


Figure 10. Body Diode Characteristic at 150 °C

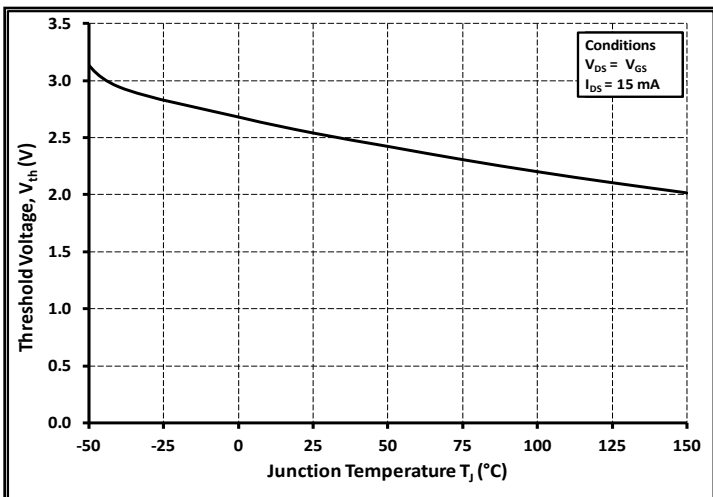


Figure 11. Threshold Voltage vs. Temperature

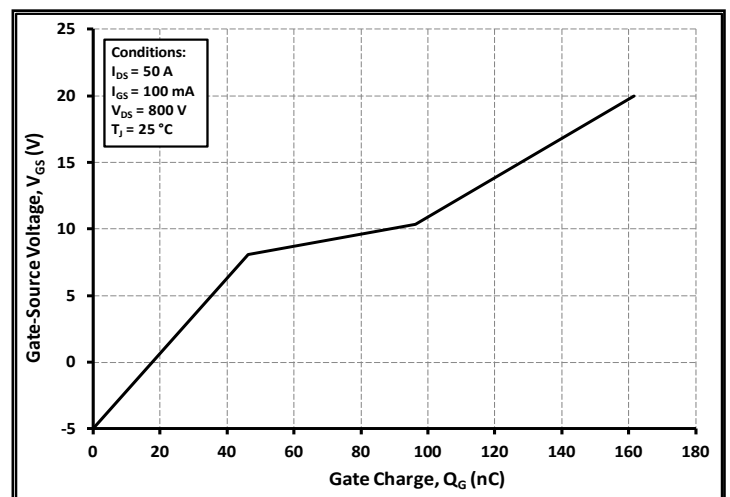


Figure 12. Gate Charge Characteristic

Typical Performance

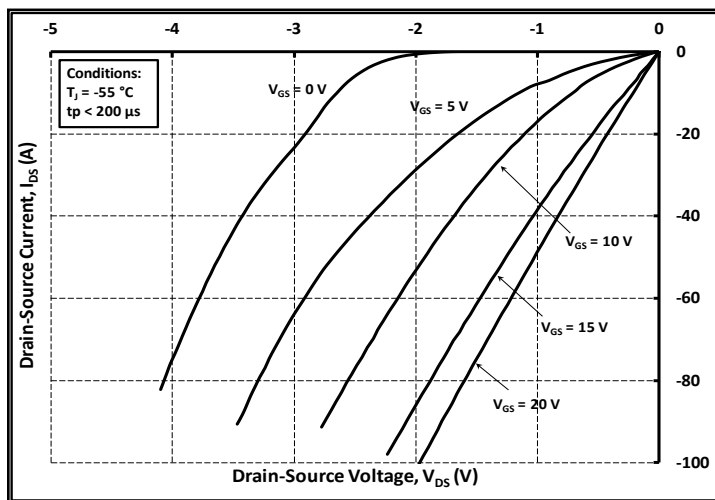


Figure 13. 3rd Quadrant Characteristic at -55 °C

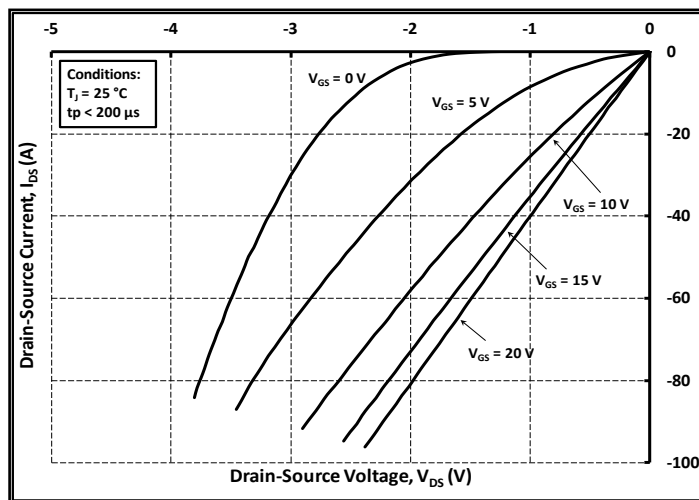


Figure 14. 3rd Quadrant Characteristic at 25 °C

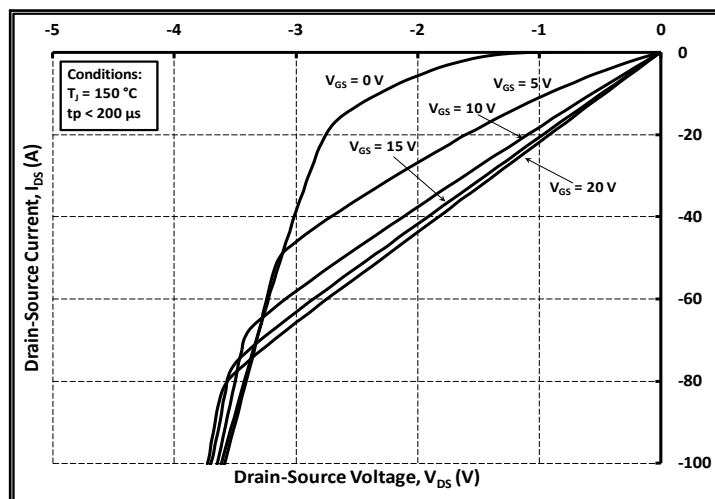


Figure 15. 3rd Quadrant Characteristic at 150 °C

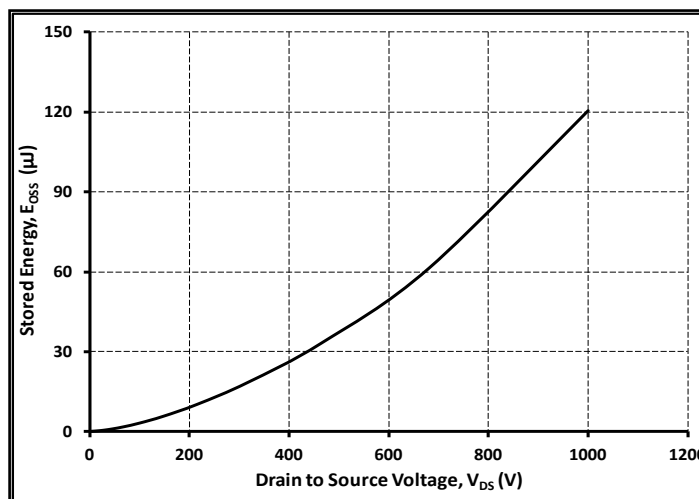


Figure 16. Output Capacitor Stored Energy

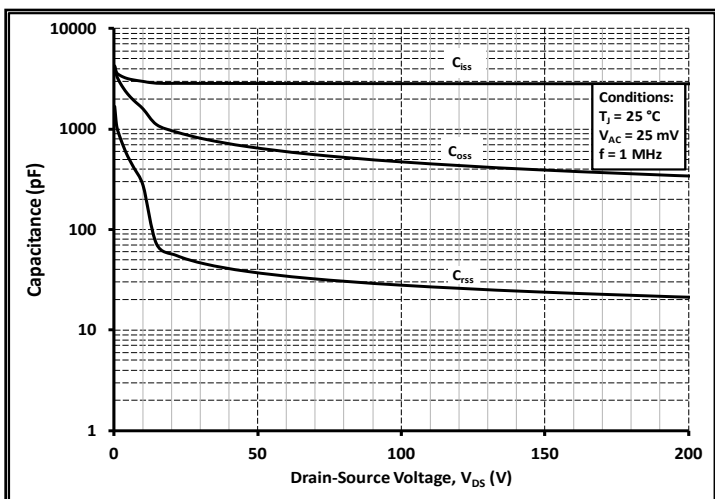


Figure 17. Capacitances vs. Drain-Source Voltage (0-200 V)

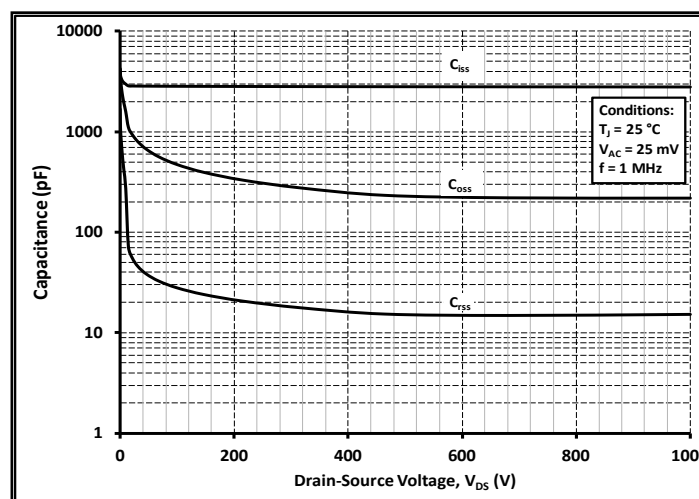


Figure 18. Capacitances vs. Drain-Source Voltage (0-1000 V)

Typical Performance

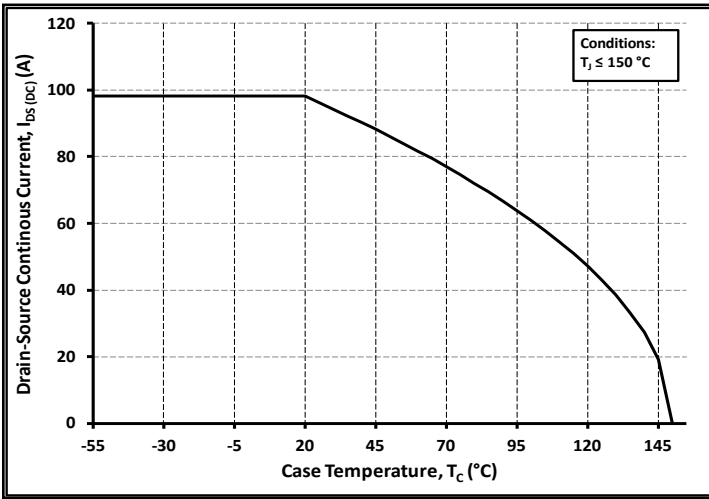


Figure 19. Continuous Drain Current Derating vs. Case Temperature

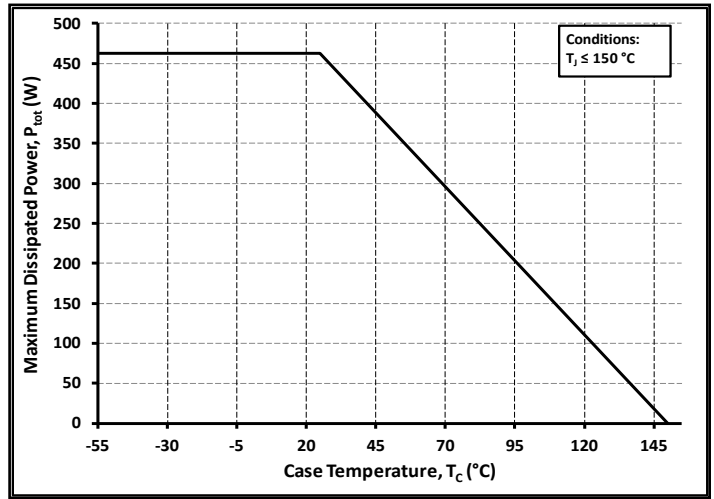


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

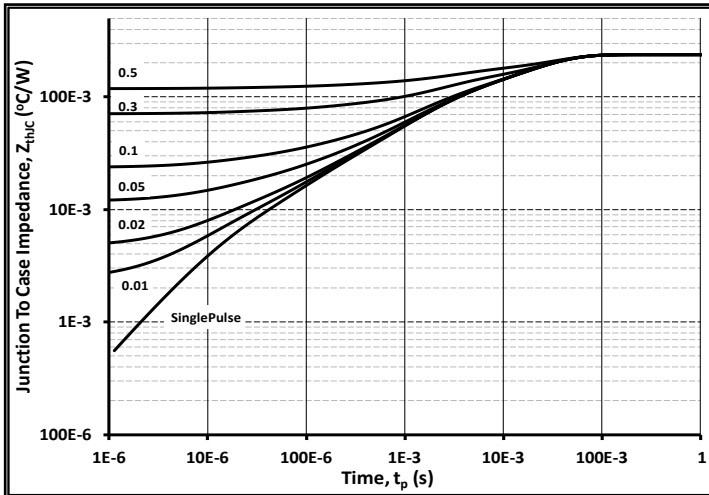


Figure 21. Transient Thermal Impedance (Junction - Case)

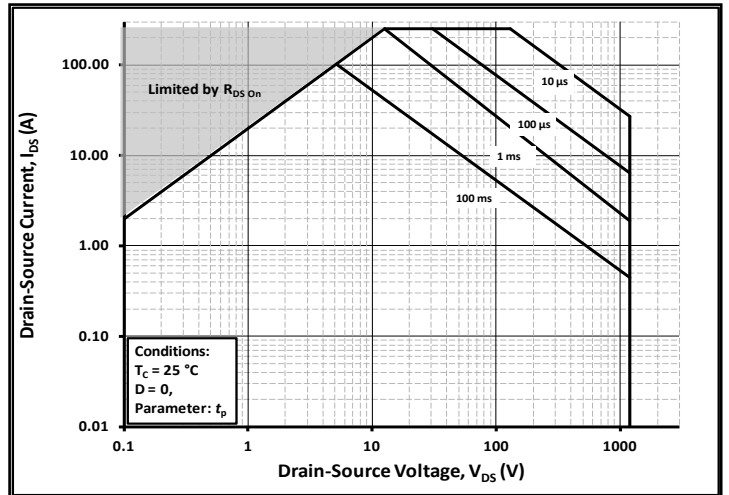


Figure 22. Safe Operating Area

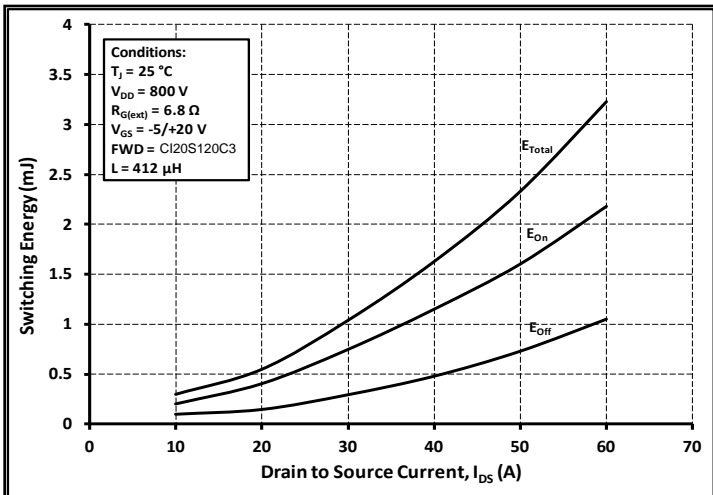


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 800V$ )

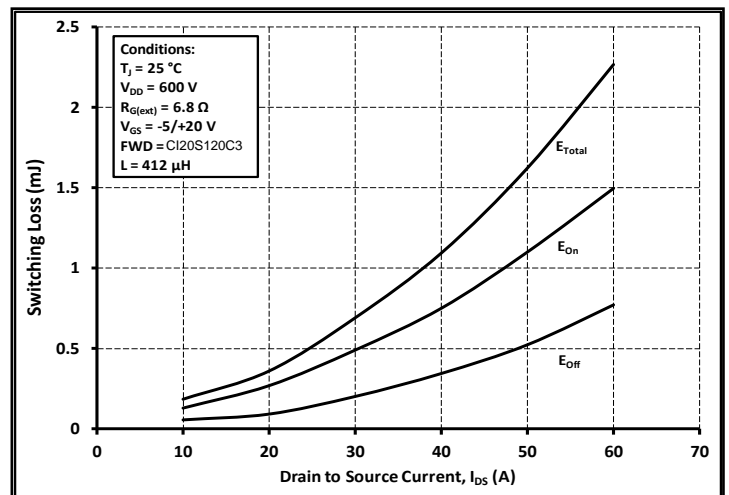


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 600V$ )

Typical Performance

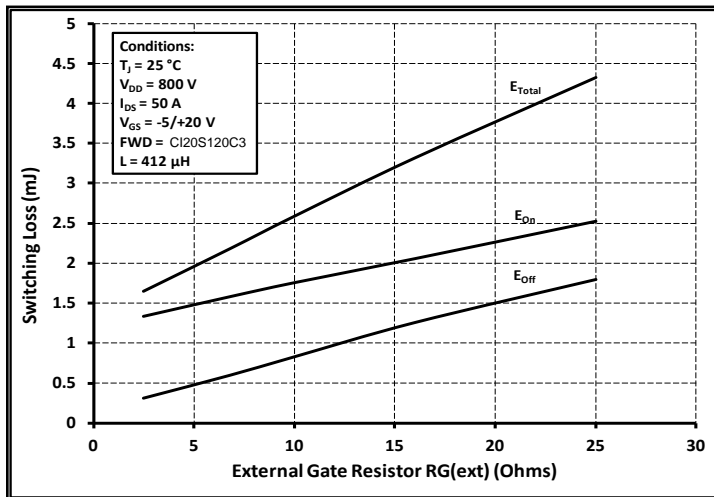


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$

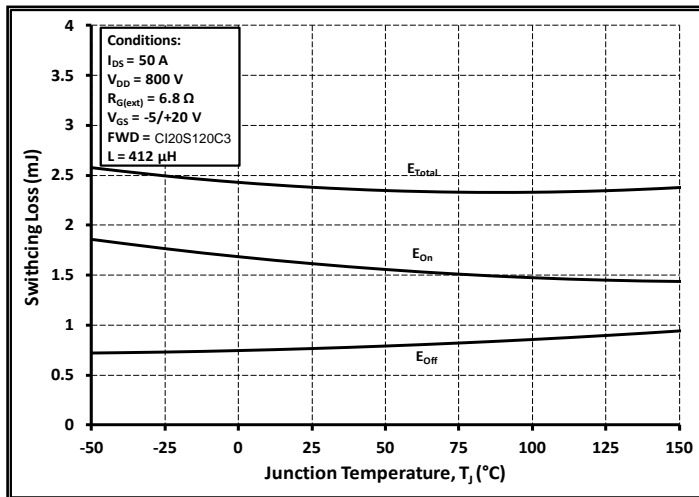


Figure 26. Clamped Inductive Switching Energy vs. Temperature

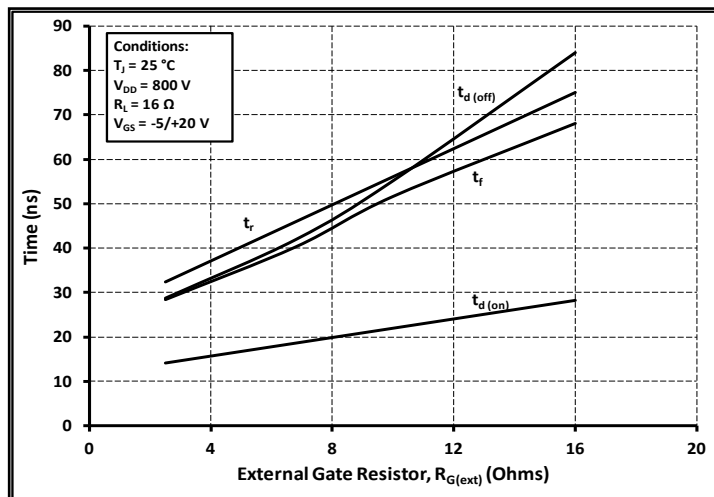


Figure 27. Switching Times vs.  $R_{G(ext)}$

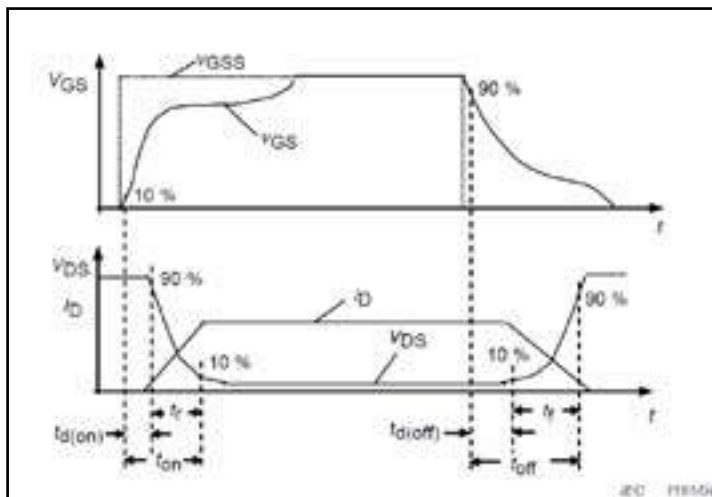


Figure 28. Switching Times Definition

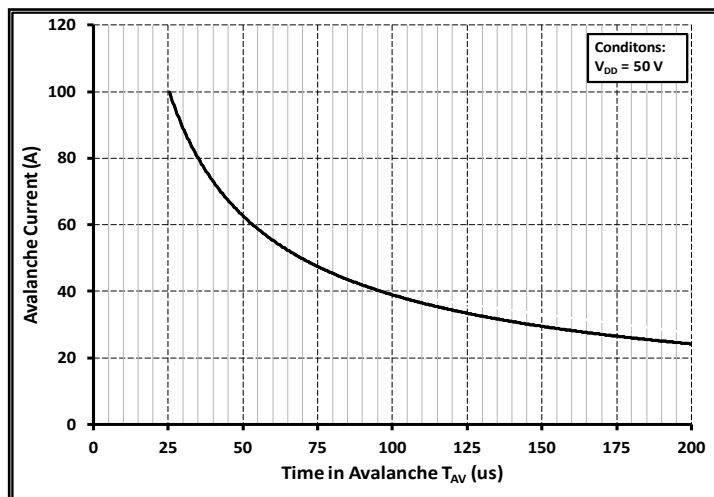


Figure 29. Single Avalanche SOA curve

Test Circuit Schematic

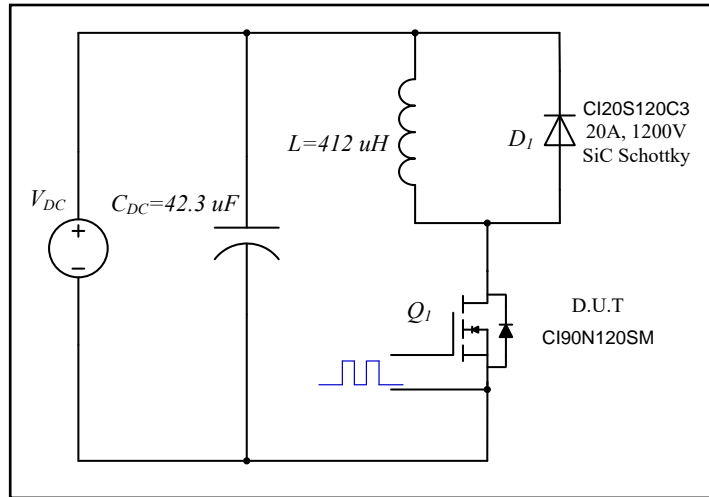


Figure 30. Clamped Inductive Switching Waveform Test Circuit

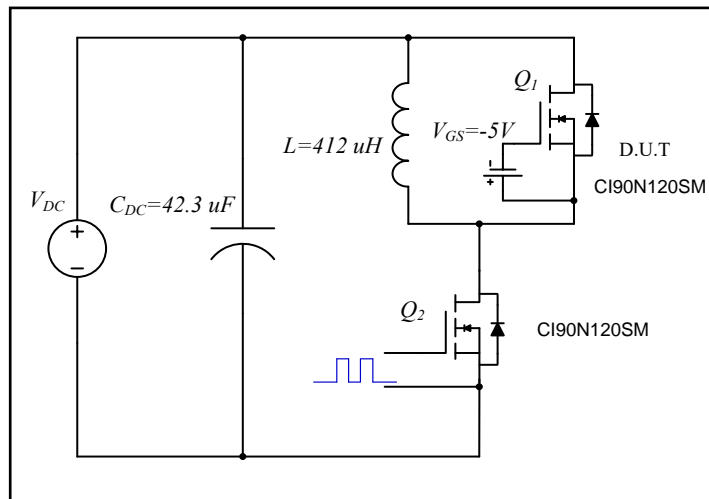
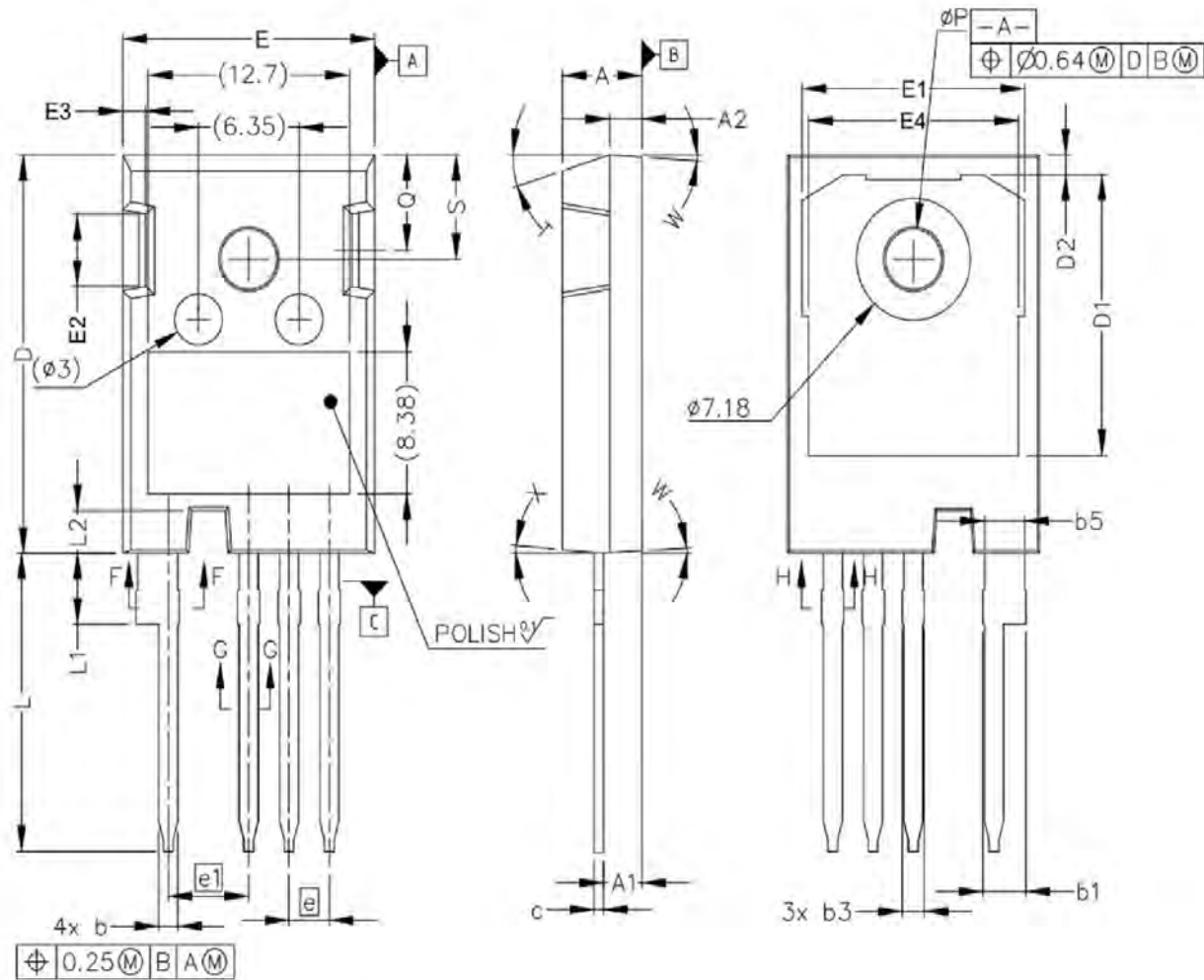


Figure 31. Body Diode Recovery Test Circuit



### Package Dimensions: TO-247-4L



SYMBOL	Mechanical Dimensions/mm			SYMBOL	Mechanical Dimensions/mm			SYMBOL	Mechanical Dimensions/mm		
	MIN	NOM	MAX						MIN	NOM	MAX
A	4.83	5.00	5.21	D	23.30	23.45	23.60	L1	3.97	4.13	4.37
A1	2.29	2.41	2.54	D1	16.25	16.55	17.65	ø P	3.51	3.6	3.65
A2	1.91	2.00	2.16	E	15.75	15.90	16.13	W	-	3.5	-
b	1.07	1.20	1.33	E1	13.10	13.65	14.15	X	-	4	-
b1	2.39	2.60	2.94	E2	3.68	5.0	5.1	Q	5.49	5.8	6.0
b2	2.39	-	2.84	e	2.54			S	6.04	6.15	6.30
c	0.55	0.60	0.68	L	17.31	17.45	17.82	T	-	17.5	-

NOTE:  
 1.The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8  
 2.Undeclared tolerance  $\pm 0.15$ , Unmarked filletRmax=0.25

NAME	TO-247-4L OUTLINE	UNIT	mm	DESIGNED	Shawn	THIRD ANGLE SYSTEM
DWGNO		PAGE	1 OF 1	CHECKED		
VERSION	Ver1.0	ISSUE DATE		APPROVED		

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[WMJ80N60C4](#) [BXP2N20L](#) [BXP2N65D](#) [BXT1150N10J](#) [BXT1700P06M](#) [TSM60NB380CP](#) [ROG](#) [RQ7L055BGTGR](#) [DMNH15H110SK3-13](#)  
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